

# TAS5421-Q1 具有负载突降和 I<sup>2</sup>C 诊断功能的 22W 单声道汽车类数字音频放大器

## 1 特性

- 单声道桥接式负载 (BTL) 数字功率放大器
- 负载为 4Ω 且总谐波失真+噪声 (THD+N) 为 10% 时的输出功率为 22W
- 4.5V 至 18V 的工作范围
- 4Ω 负载时的效率达 85%
- 差分模拟输入
- 采用可调功率限制器的 Speaker Guard™ 扬声器保护
- 75dB 电源抑制比 (PSRR)
- 负载诊断功能:
  - 开路和短路输出负载
  - 输出到电源和输出到接地短接
- 保护和监控功能:
  - 短路保护
  - 40V 负载突降保护符合 ISO-7637-2 标准
  - 在音乐播放的同时进行输出直流电平检测
  - 过热保护
  - 过压及欠压保护
- 耐热增强型 16 引脚散热薄型小外形尺寸 HTSSOP (PWP) 封装以及 PowerPAD™ 封装 (焊盘朝下)
- 设计用于汽车电磁兼容性 (EMC) 要求
- 符合 AEC-Q100 标准 2 级
- 经 ISO9000:2002 TS16949 认证
- -40°C 至 125°C 环境温度范围

## 2 应用

- 汽车类紧急呼叫 (eCall) 放大器
- 车载通讯系统
- 仪表板系统
- 信息娱乐音频

## 3 说明

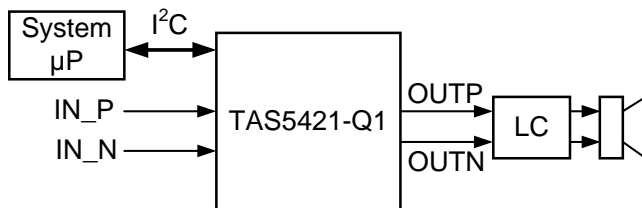
TAS5421-Q1 是一款单声道数字音频放大器，非常适用于汽车类紧急呼叫 (eCall)、车载通讯、仪表板和信息娱乐应用。该器件采用 14.4 VDC 汽车电池供电，可在负载为 4Ω 且 THD+N 不超过 10% 的情况下提供高达 22W 的功率。该器件具有较宽的工作电压范围和优异的效率，是需要起停支持或使用备用电池运行时的理想选择。集成的负载突降保护能够缩减外部电压钳位电路的成本与尺寸，板载负载诊断功能能够通过 I<sup>2</sup>C 报告扬声器状态。

### 器件信息(1)

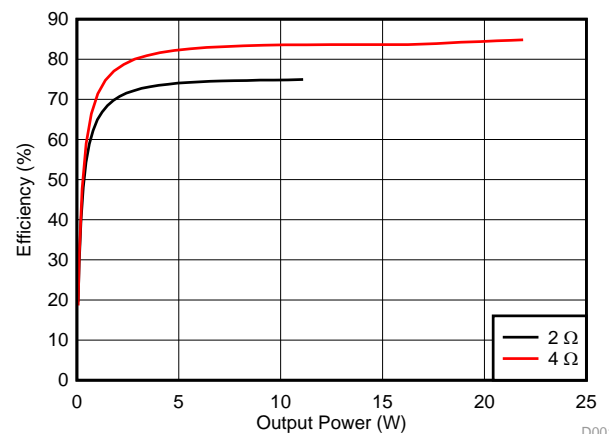
器件型号	封装	封装尺寸 (标称值)
TAS5421-Q1	HTSSOP (16)	5.00mm x 4.40mm

(1) 如需了解所有可用封装，请见数据表末尾的可订购产品附录。

简化框图



输出功率效率



D001



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## 4 修订历史记录

### Changes from Revision B (July 2014) to Revision C

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•	Moved T <sub>stg</sub> from Handling Ratings table to Absolute Maximum Ratings table .....	3
•	Changed Handling Ratings table to ESD Ratings .....	4
•	In "1. Load Diagnostics" paragraph, changed "at start-up" to "on de-assertion of STANDBY" and appended two new sentences .....	12
•	Changed Section number of I <sup>2</sup> C Serial Communication Bus from 7.4 to 7.3.7 .....	13
•	Changed <a href="#">Table 3</a> .....	16
•	Added disclaimer to beginning of <i>Application and Implementation</i> section .....	18
•	Added <i>Power Supply Recommendations</i> section and moved the contents of former Section 8.2.1.5 here.....	22
•	Created a <i>Layout Examples</i> section to contain former sections 9.1.1 through 9.1.4.....	22
•	Placed text ahead of graphics for <a href="#">Figure 18</a> through <a href="#">Figure 21</a> .....	22
•	添加了第三方组件免责声明.....	24

### Changes from Revision A (July 2014) to Revision B

Page

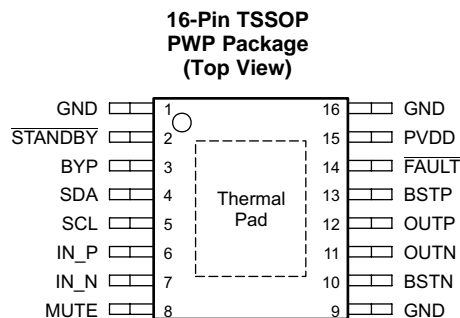
•	数据表状态从产品预览更改为生产数据.....	1
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### Changes from Original (March 2014) to Revision A

Page

•	Added content to the preliminary data sheet to create the full PRODUCT PREVIEW data sheet .....	3
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## 5 Pin Configuration and Functions



### Pin Functions

PIN		TYPE <sup>(1)</sup>	DESCRIPTION
NAME	NO.		
BSTN	10	AI	Bootstrap for negative-output high-side FET
BSTP	13	AI	Bootstrap for positive-output high-side FET
BYP	3	PBY	Voltage-regulator bypass-capacitor pin
$\overline{\text{FAULT}}$	14	DO	Active-low open-drain output used to report faults
GND	1, 9, 16	GND	Ground
IN_N	7	AI	Inverting analog input
IN_P	6	AI	Non-inverting analog input
MUTE	8	DI	Mute input, active-high (no internal pullup or pulldown)
OUTN	11	PO	Output (-)
OUTP	12	PO	Output (+)
PVDD	15	PWR	Power supply
SCL	5	DI	I <sup>2</sup> C clock
SDA	4	DI/DO	I <sup>2</sup> C data
$\overline{\text{STANDBY}}$	2	DI	Active-low STANDBY pin (no internal pullup or pulldown)
Thermal pad	—	—	Must be soldered to ground

(1) DI = digital input, DO = digital output, AI = analog input, PWR = power supply, PBY = power bypass, PO = power output, GND = ground

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) <sup>(1)</sup>

			MIN	MAX	UNIT
Input Voltage	DC supply voltage range, $V_{(PVDD)}$	Relative to GND	-0.3	30	V
	Pulsed supply voltage range, $V_{(PVDD\_MAX)}$	$t \leq 400$ ms exposure	-1	40	
	Supply voltage ramp rate, $\Delta V_{(PVDD\_RAMP)}$			15	V/ms
	For SCL, SDA, $\overline{\text{STANDBY}}$ pins	Relative to GND	-0.3	5	V
	For IN_N, IN_P, and MUTE pins	Relative to GND	-0.3	6.5	
Current	DC current on PVDD, GND and OUTx pins, $I_{(PVDD)}$ , $I_O$			$\pm 4$	A
	Maximum current, on all input pins, $I_{(IN\_MAX)}$ <sup>(2)</sup>			$\pm 1$	mA
	Maximum sink current for open-drain pin, $I_{(IN\_ODMAX)}$			7	
Storage temperature, $T_{stg}$			-55	150	°C

(1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) See the [Application Information](#) section for information on analog input voltage and ac coupling.

## 6.2 ESD Ratings

		VALUE	UNIT	
V <sub>(ESD)</sub>	Electrostatic discharge	Human-body model (HBM), per AEC Q100-002 <sup>(1)</sup>	±3500	
		Charged-device model (CDM), per AEC Q100-011	All pins	±1000
			Corner pins (1, 8, 9, and 16)	±1000

(1) AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

## 6.3 Recommended Operating Conditions

		MIN	TYP	MAX	UNIT
V <sub>(PVDD_OP)</sub>	Supply voltage range relative to GND. Includes ac transients, requires proper decoupling. <sup>(1)</sup>	4-Ω ±20% load (or higher)	4.5	14.4	18
		2-Ω ±20% load	5	14.4	18
V <sub>(PVDD_RIPPLE)</sub>	Maximum ripple on PVDD	V <sub>(PVDD)</sub> < 8 V			1
V <sub>(AIN)</sub> <sup>(2)</sup>	Analog audio input-signal level	AC-coupled input voltage			0.25–1 <sup>(3)</sup>
V <sub>(IH_STANDBY)</sub>	$\overline{\text{STANDBY}}$ pin input voltage for logic-level high	2			V
V <sub>(IL_STANDBY)</sub>	$\overline{\text{STANDBY}}$ pin input voltage for logic-level low	0.7			V
V <sub>(IH_SCL)</sub>	SCL pin input voltage for logic-level high	2.1			5.5
V <sub>(IH_SDA)</sub>	SDA pin input voltage for logic-level high	2.1			5.5
V <sub>(IL_SCL)</sub>	SCL pin input voltage for logic-level low	-0.5			1.1
V <sub>(IL_SDA)</sub>	SDA pin input voltage for logic-level low	-0.5			1.1
T <sub>A</sub>	Ambient temperature	-40			125
R <sub>(L)</sub>	Nominal speaker load impedance	When using low-impedance loads, do not exceed overcurrent limit.			2, 4, 16
V <sub>(PU)</sub>	Pullup voltage supply (for open-drain logic outputs)	3, 3.3, 3.6			V
R <sub>(PU_EXT)</sub>	External pullup resistor on open-drain logic outputs	Resistor connected between open-drain logic output and V <sub>(PU)</sub> supply.			10, 50
R <sub>(PU_I2C)</sub>	I <sup>2</sup> C pullup resistance on SDA and SCL pins	1, 4.7, 10			kΩ
C <sub>(PVDD)</sub>	External capacitor on the PVDD pin, typical value ± 20% <sup>(1)</sup>	10			μF
C <sub>(BYP)</sub>	External capacitor on the BYP pin, typical value ± 10%	1			μF
C <sub>(OUT)</sub>	External capacitance to GND on OUT_X pins	4			μF
C <sub>(IN)</sub>	External capacitance to analog input pin in series with input signal	1			μF
C <sub>(BSTN)</sub> , C <sub>(BSTP)</sub>	External bootstrap capacitor, typical value ± 20%	220			nF

(1) See the [Power Supply Recommendations](#) section.

(2) Signal input for full unclipped output with gains of 36 dB, 32 dB, 26 dB, and 20 dB

(3) Maximum recommended input voltage is determined by the gain setting.

## 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		TAS5421-Q1	UNIT
		PWP (HTSSOP)	
		16 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	39.4	°C/W
R <sub>θJC(top)</sub>	Junction-to-case (top) thermal resistance	24.9	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	20	°C/W
ψ <sub>JT</sub>	Junction-to-top characterization parameter	0.6	°C/W
ψ <sub>JB</sub>	Junction-to-board characterization parameter	19.8	°C/W
R <sub>θJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	2	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, [SPRA953](#).

## 6.5 Electrical Characteristics

 $T_C = 25^\circ\text{C}$ ,  $PVDD = 14.4\text{ V}$ ,  $R_L = 4\ \Omega$ ,  $P_{(O)} = 1\text{ W/ch}$ , AES17 filter, default I<sup>2</sup>C settings (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
<b>OPERATING CURRENT</b>						
PVDD idle current	In PLAY mode, no audio present		16		mA	
PVDD standby current	STANDBY mode, MUTE = 0 V		5	20	$\mu\text{A}$	
<b>OUTPUT POWER</b>						
Output power per channel	4 $\Omega$ , THD+N $\leq$ 1%, 1 kHz, $T_C = 75^\circ\text{C}$		18		W	
	4 $\Omega$ , THD+N = 10%, 1 kHz, $T_C = 75^\circ\text{C}$		22			
Power efficiency	4 $\Omega$ , $P_{(O)} = 22\text{ W}$ (10% THD)		85%			
<b>AUDIO PERFORMANCE</b>						
Noise voltage at output	G = 20 dB, zero input, and A-weighting		65		$\mu\text{V}$	
Common-mode rejection ratio	f = 1 kHz, 100 mVrms referenced to GND, G = 20 dB		63		dB	
Power-supply rejection ratio	PVDD = 14.4 Vdc + 1 Vrms, f = 1 kHz		75			
Total harmonic distortion + noise	$P_{(O)} = 1\text{ W}$ , f = 1 kHz		0.05 %			
Switching frequency	Switching frequency selectable for AM interference avoidance		400		kHz	
			500			
Internal common-mode input bias voltage	Internal bias applied to IN_N, IN_P pins		3		V	
Voltage gain ( $V_O/V_{IN}$ )	Source impedance = 0 $\Omega$ , $P_{(O)} = 1\text{ W}$		19	20	21	dB
			25	26	27	
			31	32	33	
			35	36	37	
<b>PWM OUTPUT STAGE</b>						
FET drain-to-source resistance	$T_J = 25^\circ\text{C}$		180		m $\Omega$	
Output offset voltage	Zero input signal, G = 20 dB			$\pm 25$	mV	
<b>PVDD OVERVOLTAGE (OV) PROTECTION</b>						
PVDD overvoltage-shutdown set		19.5	21	22.5	V	
PVDD overvoltage-shutdown hysteresis			0.6		V	
<b>PVDD UNDERVOLTAGE (UV) PROTECTION</b>						
PVDD undervoltage-shutdown set		3.6	4	4.4	V	
PVDD undervoltage-shutdown hysteresis			0.25		V	
<b>BYP</b>						
BYP pin voltage		6.4	6.9	7.4	V	
<b>POWER-ON RESET (POR)</b>						
PVDD voltage for POR				4.1	V	
PVDD recovery hysteresis voltage for POR			0.3		V	

**Electrical Characteristics (continued)**
 $T_C = 25^\circ\text{C}$ ,  $PVDD = 14.4\text{ V}$ ,  $R_L = 4\ \Omega$ ,  $P_{(O)} = 1\text{ W/ch}$ , AES17 filter, default I<sup>2</sup>C settings (unless otherwise noted)

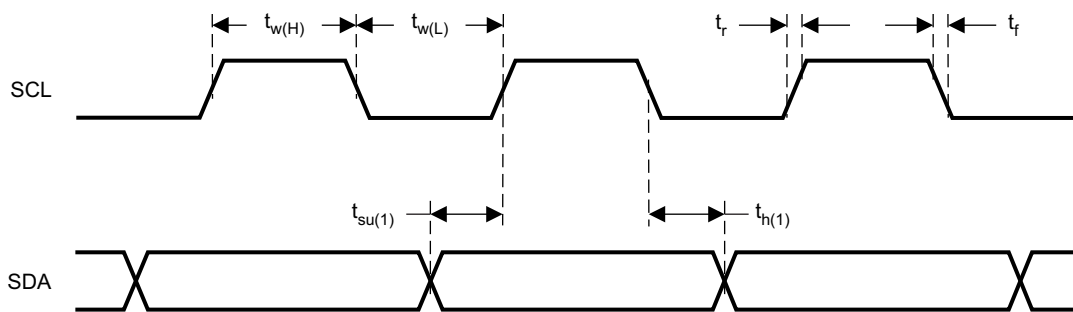
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>OVERTEMPERATURE (OT) PROTECTION</b>					
Junction temperature for overtemperature shutdown		155	170		°C
Junction temperature overtemperature shutdown hysteresis			15		°C
<b>OVERCURRENT (OC) SHUTDOWN PROTECTION</b>					
Maximum current (peak output current)			3.5		A
<b>STANDBY PIN</b>					
STANDBY pin current			0.1	0.2	μA
<b>DC DETECT</b>					
DC detect threshold			2.9		V
DC detect step response time				700	ms
<b>FAULT REPORT</b>					
FAULT pin output voltage for logic-level high (open-drain logic output)	External 47-kΩ pullup resistor to 3.3 V	2.4			V
FAULT pin output voltage for logic-level low (open-drain logic output)			0.5		V
<b>LOAD DIAGNOSTICS</b>					
Resistance to detect a short from OUT pin(s) to PVDD or ground				200	Ω
Open-circuit detection threshold	Including speaker wires	70	95	120	Ω
Short-circuit detection threshold		0.9	1.2	1.5	Ω
<b>I<sup>2</sup>C</b>					
SDA pin output voltage for logic-level high	$R_{(P_{U\_I2C})} = 4.7\text{-k}\Omega$ pullup, supply voltage = 3.3 V or 5 V	2.4			V
SDA pin output voltage for logic-level low	3-mA sink current			0.4	V
Capacitance for SCL and SDA pins				10	pF

## 6.6 Timing Requirements for I<sup>2</sup>C Interface Signals

over recommended operating conditions (unless otherwise noted)

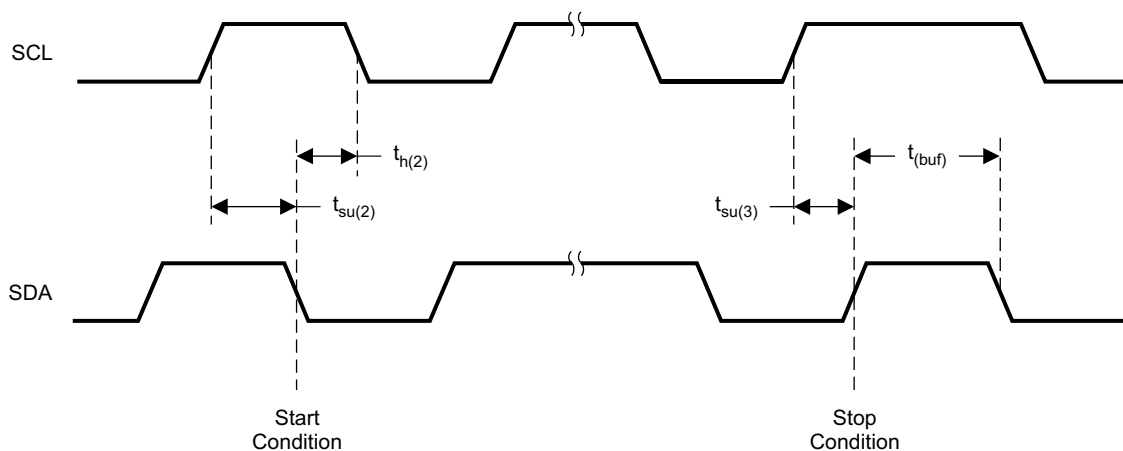
PARAMETER		MIN	TYP	MAX	UNIT
$f_{(SCL)}$	SCL clock frequency			400	kHz
$t_r$	Rise time for both SDA and SCL signals			300	ns
$t_f$	Fall time for both SDA and SCL signals			300	ns
$t_{w(H)}$	SCL pulse duration, high	0.6			$\mu$ s
$t_{w(L)}$	SCL pulse duration, low	1.3			$\mu$ s
$t_{su(2)}$	Setup time for START condition	0.6			$\mu$ s
$t_{h(2)}$	START condition hold time before generation of first clock pulse	0.6			$\mu$ s
$t_{su(1)}$	Data setup time	100			ns
$t_{h(1)}$	Data hold time	0 <sup>(1)</sup>			ns
$t_{su(3)}$	Setup time for STOP condition	0.6			$\mu$ s
$C_{(B)}$	Load capacitance for each bus line			400	pF

- (1) A device must internally provide a hold time of at least 300 ns for the SDA signal to bridge the undefined region of the falling edge of SCL.



T0027-03

Figure 1. SCL and SDA Timing



T0028-02

Figure 2. Timing for Start and Stop Conditions

### 6.7 Typical Characteristics

PVDD = 14.4 V, T<sub>A</sub> = 25°C, P<sub>(O)</sub> = 1 W, 1-kHz input, default I<sup>2</sup>C settings (unless otherwise noted)

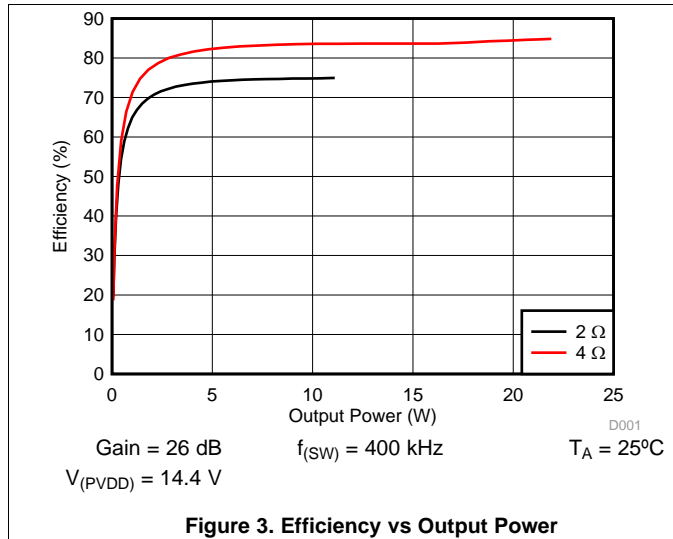


Figure 3. Efficiency vs Output Power

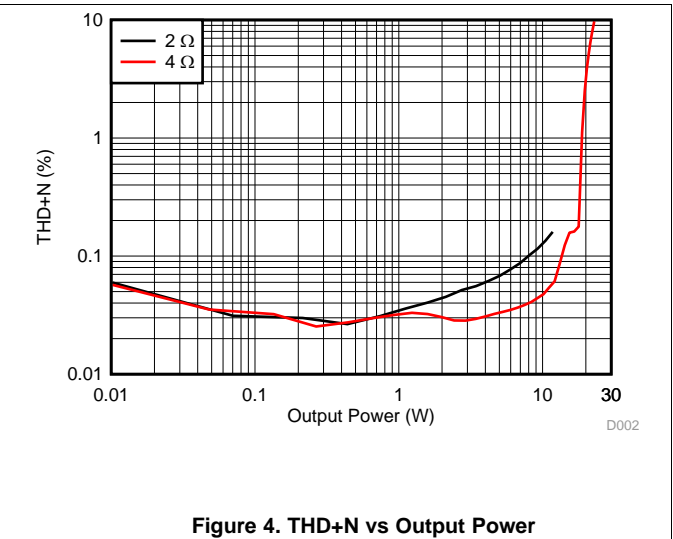


Figure 4. THD+N vs Output Power

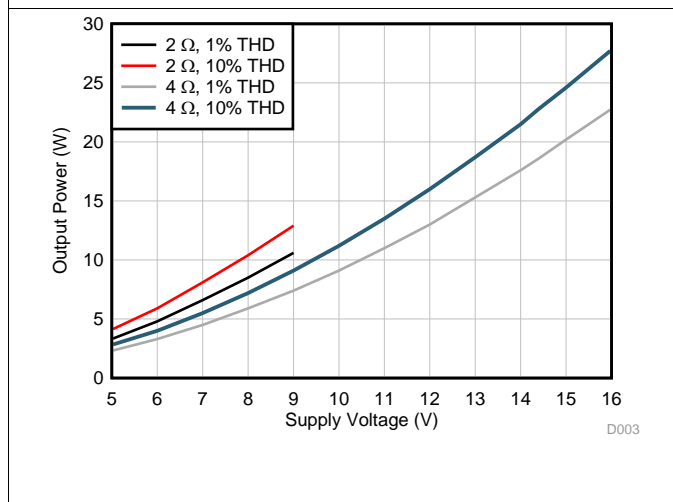


Figure 5. Output Power vs PVDD

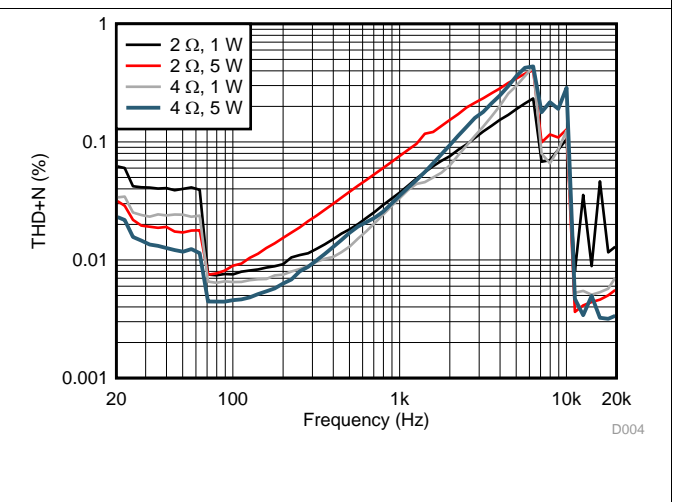


Figure 6. THD+N vs Frequency

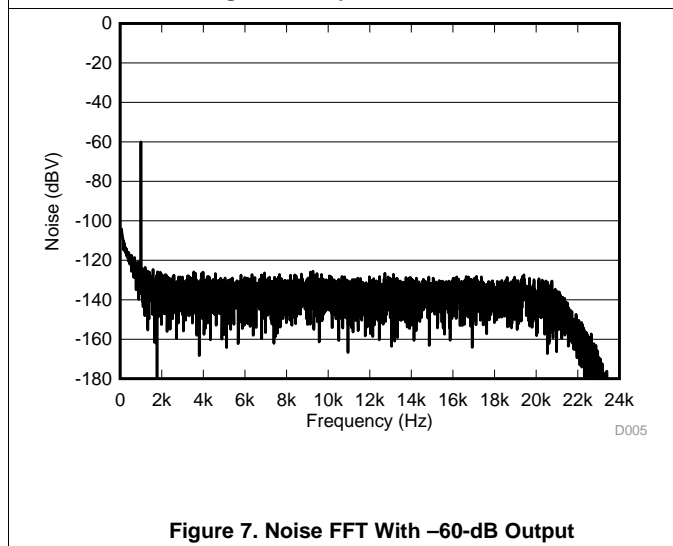


Figure 7. Noise FFT With -60-dB Output

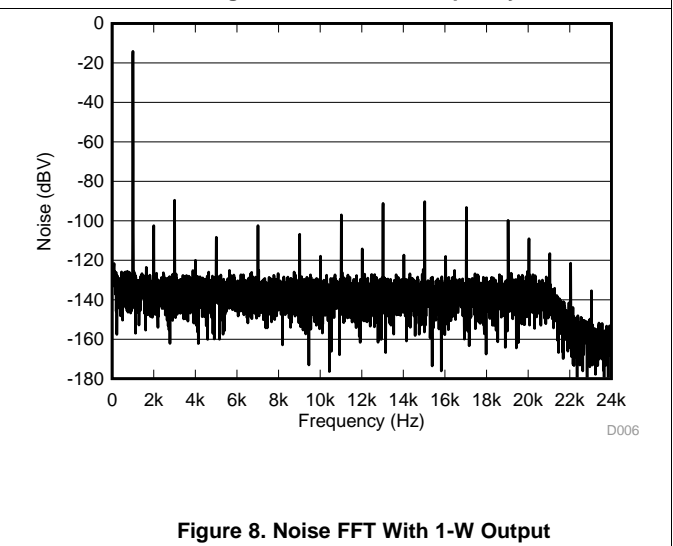
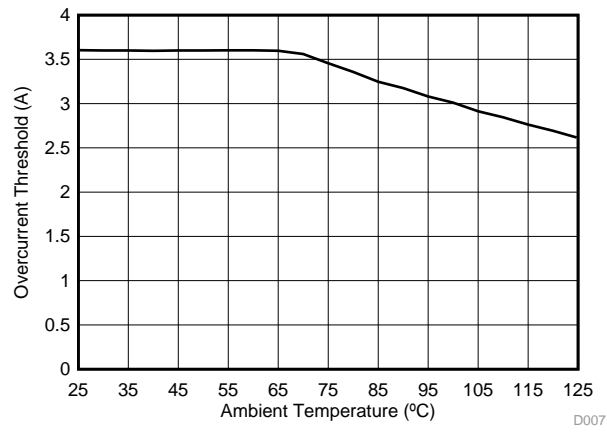


Figure 8. Noise FFT With 1-W Output

**Typical Characteristics (continued)**

PVDD = 14.4 V, T<sub>A</sub> = 25°C, P<sub>(O)</sub> = 1 W, 1-kHz input, default I<sup>2</sup>C settings (unless otherwise noted)



**Figure 9. Overcurrent Threshold Versus Temperature**

## 7 Detailed Description

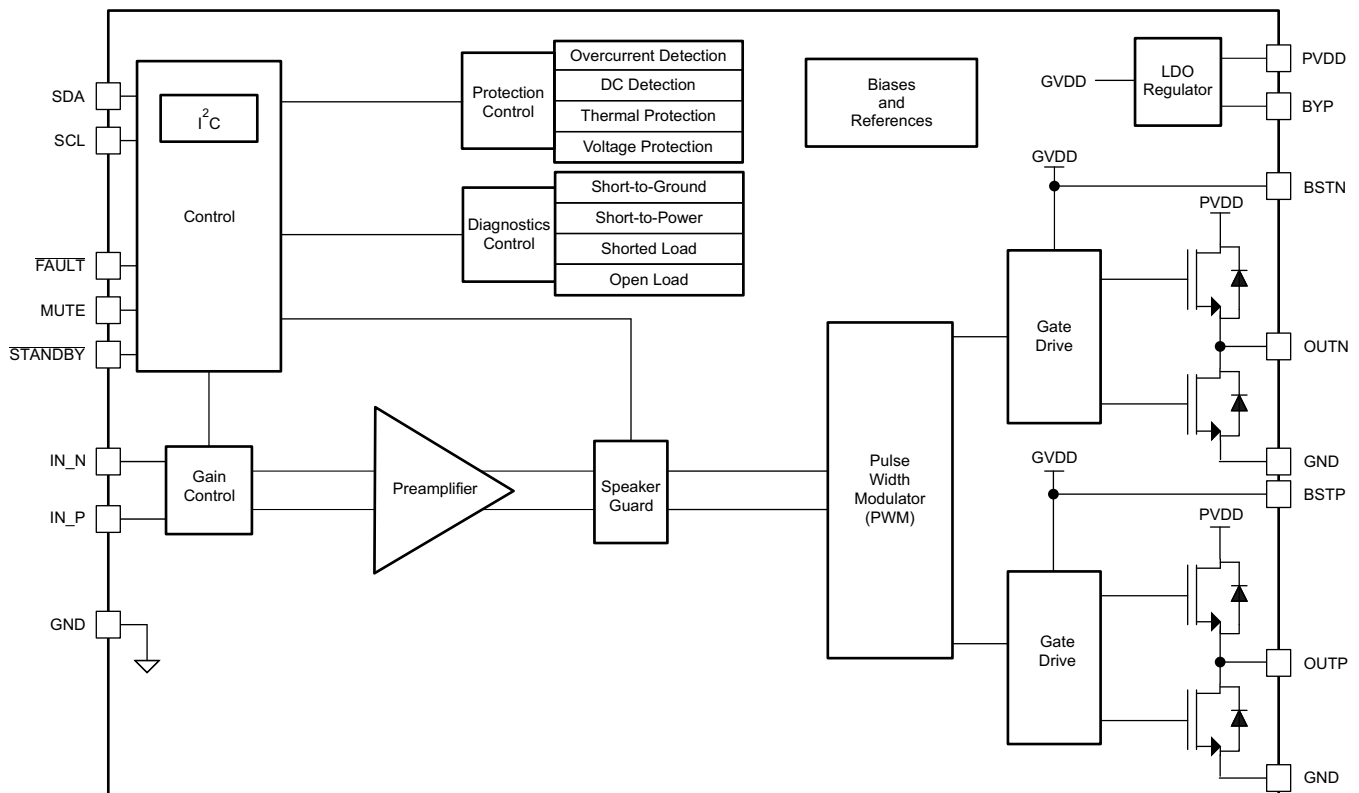
### 7.1 Overview

The TAS5421-Q1 is a mono analog-input audio amplifier for use in the automotive environment. The design uses an ultra-efficient class-D technology developed by Texas Instruments, but with features added for the automotive industry. This technology allows for reduced power consumption, reduced heat, and reduced peak currents in the electrical system. The device realizes an audio sound system design with smaller size and lower weight than traditional class-AB solutions.

There are seven core design blocks:

- PWM
- Gate drive
- Power FETs
- Diagnostics
- Protection
- Power supply
- I<sup>2</sup>C serial communication bus

### 7.2 Functional Block Diagram



### 7.3 Feature Description

#### 7.3.1 Analog Audio Input and Pre-amplifier

The differential input stage of the amplifier cancels common-mode noise that appears on the inputs. For a differential audio source, connect the positive lead to IN\_P and the negative lead to IN\_N. The inputs must be ac-coupled to minimize the output dc-offset and ensure correct ramping of the output voltages. For good transient performance, the impedance seen at each of the two differential inputs should be the same.

The gain setting impacts the analog input impedance of the amplifier. See [Table 1](#) for typical values.

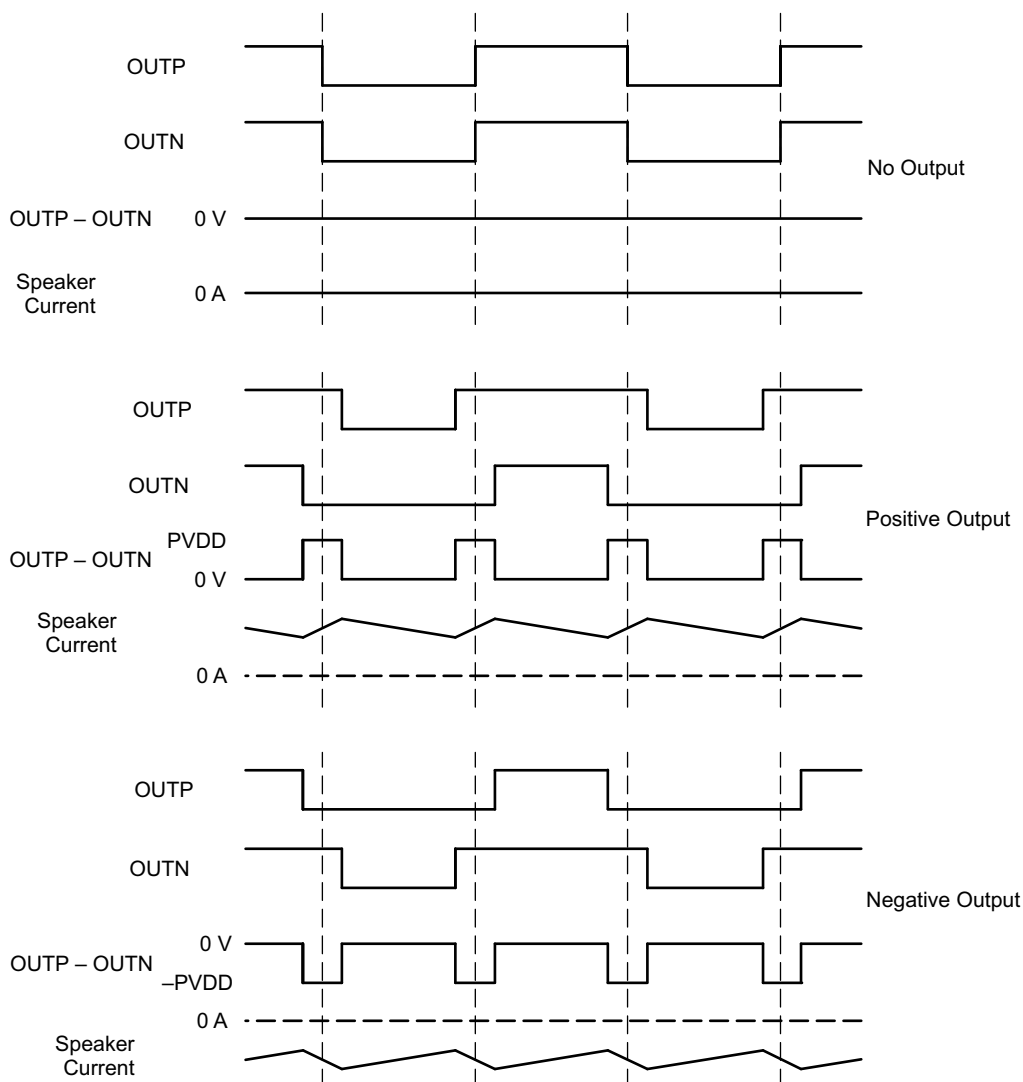
**Table 1. Input Impedance and Gain**

Gain	Input Impedance
20 dB	60 kΩ ± 20%
26 dB	30 kΩ ± 20%
32 dB	15 kΩ ± 20%
36 dB	9 kΩ ± 20%

**7.3.2 Pulse-Width Modulator (PWM)**

The PWM converts the analog signal from the preamplifier into a switched signal of varying duty cycle. This is the critical stage that defines the class-D architecture. In the TAS5421-Q1, the modulator is an advanced design with high bandwidth, low noise, low distortion, and excellent stability.

The pulse-width modulation scheme allows increased efficiency at low power. Each output is switching from 0 V to PVDD. The OUTP and OUTN pins are in phase with each other with no input, so that there is little or no current in the speaker. The duty cycle of OUTP is greater than 50% and OUTN is less than 50% for positive output voltages. The duty cycle of OUTN is greater than 50% and that of OUTP is less than 50% for negative output voltages. The voltage across the load is at 0 V through most of the switching period, reducing power loss.



**Figure 10. BD Mode Modulation**

### 7.3.3 Gate Drive

The gate driver accepts the low-voltage PWM signal and level shifts it to drive a high-current, full-bridge, power FET stage. The device uses proprietary techniques to optimize EMI and audio performance.

### 7.3.4 Power FETs

The BTL output comprises four matched N-channel FETs for high efficiency and maximum power transfer to the load. By design, the FETs withstand large voltage transients during a load-dump event.

### 7.3.5 Load Diagnostics

The device incorporates load diagnostic circuitry designed for detecting and determining the status of output connections. The device supports the following diagnostics:

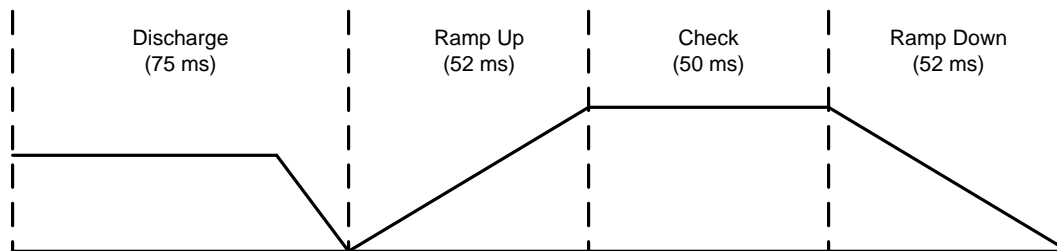
- Short to GND
- Short to PVDD
- Short across load
- Open load

The device reports the presence of any of the short or open conditions to the system via I<sup>2</sup>C register read.

1. **Load Diagnostics**—The load diagnostic function runs on de-assertion of STANDBY or when the device is in a fault state (dc detect, overcurrent, overvoltage, undervoltage, and overtemperature). During this test, the outputs are in a Hi-Z state. The device determines whether the output is a short to GND, short to PVDD, open load, or shorted load. The load diagnostic biases the output, which therefore requires limiting the capacitance value for proper functioning; see the [Recommended Operating Conditions](#). The load diagnostic test takes approximately 229 ms to run. Note that the *check* phase repeats up to 5 times if a fault is present or a large capacitor to GND is present on the output. On detection of an open load, the output still operates. On detection of any other fault condition, the output goes into a Hi-Z state, and the device checks the load continuously until removal of the fault condition. After detection of a normal output condition, the audio output starts. The load diagnostics run after every other overvoltage (OV) event. The load diagnostic for open load only has I<sup>2</sup>C reporting. All other faults have I<sup>2</sup>C and FAULT pin assertion.

The device performs load diagnostic tests as shown in [Figure 11](#).

[Figure 12](#) illustrates how the diagnostics determine the load based on output conditions.



**Figure 11. Load Diagnostics Sequence of Events**

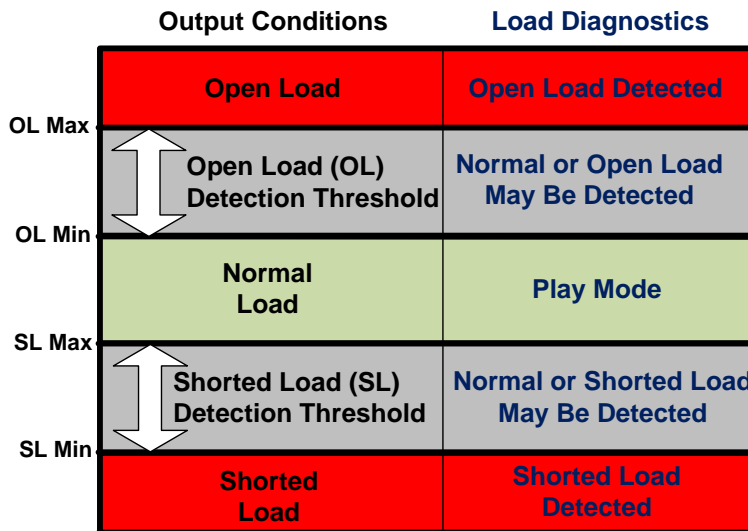


Figure 12. Load Diagnostic Reporting Thresholds

- Faults During Load Diagnostics**—If the device detects a fault (overtemperature, overvoltage, undervoltage) during the load diagnostics test, the device exits the load diagnostics, which may result in a pop or click on the output.

### 7.3.6 Protection and Monitoring

- Overcurrent Shutdown (OCS)**—The overcurrent shutdown forces the output into Hi-Z. The device asserts the FAULT pin and updates the I<sup>2</sup>C register.
- DC Detect**—This circuit checks for a dc offset continuously during normal operation at the output of the amplifier. If a dc offset occurs, the device asserts the FAULT pin and updates the I<sup>2</sup>C register. Note that the dc detection threshold follows PVDD changes.
- Overtemperature Shutdown (OTS)**—The device shuts down when the die junction temperature reaches the overtemperature threshold. The device asserts the FAULT pin asserts and updates I<sup>2</sup>C register. Recovery is automatic when the temperature returns to a safe level.
- Undervoltage (UV)**—The undervoltage (UV) protection detects low voltages on PVDD. In the event of an undervoltage condition, the device asserts the FAULT pin and resets the I<sup>2</sup>C register.
- Power-On Reset (POR)**—Power-on reset (POR) occurs when PVDD drops below the POR threshold. A POR event causes the I<sup>2</sup>C bus to go into a high-impedance state. After recovery from the POR event, the device restarts automatically with default I<sup>2</sup>C register settings. The I<sup>2</sup>C is active as long as the device is not in POR.
- Overvoltage (OV) and Load Dump**—OV protection detects high voltages on PVDD. If PVDD reaches the overvoltage threshold, the device asserts the FAULT pin and updates the I<sup>2</sup>C register. The device can withstand 40-V load-dump voltage spikes.
- SpeakerGuard** protection circuitry limits the output voltage to the value selected in I<sup>2</sup>C register 0x03. This value determines both the positive and negative limits. One can use this feature to improve battery life or protect the speaker from exceeding its excursion limits.
- Adjacent-Pin Shorts**—The device design is such that shorts between adjacent pins do not cause damage.

### 7.3.7 I<sup>2</sup>C Serial Communication Bus

The device communicates with the system processor via the I<sup>2</sup>C serial communication bus as an I<sup>2</sup>C slave-only device. The processor can poll the device via I<sup>2</sup>C to determine the operating status. All reports of fault conditions and detections are via I<sup>2</sup>C. The system can also set numerous features and operating conditions via I<sup>2</sup>C. The I<sup>2</sup>C interface is active approximately 1 ms after the STANDBY pin is high.

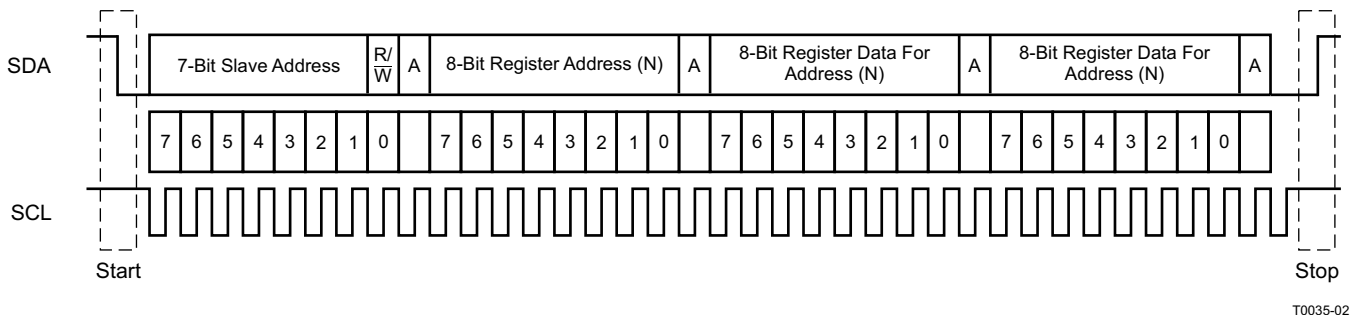
The I<sup>2</sup>C interface controls the following device features:

- Changing gain setting to 20 dB, 26 dB, 32 dB, or 36 dB.
- Controlling peak voltage value of SpeakerGuard protection circuitry
- Reporting load diagnostic results
- Changing of switching frequency for AM radio avoidance

### 7.3.7.1 I<sup>2</sup>C Bus Protocol

The device has a bidirectional serial control interface that is compatible with the Inter IC (I<sup>2</sup>C) bus protocol and supports 400-kbps data transfer rates for random and sequential write and read operations. This is a slave-only device that does not support a multimaster bus environment or wait-state insertion. The master device uses the I<sup>2</sup>C control interface to program the registers of the device and to read device status.

The I<sup>2</sup>C bus employs two signals, SDA (data) and SCL (clock), to communicate between integrated circuits in a system. Data transfer on the bus is serial, one bit at a time. The transfer of address and data is in byte (8-bit) format with the most-significant bit (MSB) transferred first. In addition, the receiving device acknowledges each byte transferred on the bus with an acknowledge bit. Each transfer operation begins with the master device driving a start condition on the bus and ends with the master device driving a stop condition on the bus. The bus uses transitions on the data pin (SDA) while the clock is HIGH to indicate start and stop conditions. A HIGH-to-LOW transition on SDA indicates a start, and a LOW-to-HIGH transition indicates a stop. Normal data bit transitions must occur within the low time of the clock period. Figure 13 shows these conditions. The master generates the 7-bit slave address and the read/write (R/W) bit to open communication with another device and then waits for an acknowledge condition. The device holds SDA LOW during the acknowledge clock period to indicate an acknowledgment. When this occurs, the master transmits the next byte of the sequence. The address for each device is a unique 7-bit slave address plus R/W bit (1 byte). All compatible devices share the same signals via a bidirectional bus using a wired-AND connection. The SDA and SCL signals require the use of an external pullup resistor to set the HIGH level for the bus. There is no limit on the number of bytes that the communicating devices can transmit between start and stop conditions. After transfer of the last word, the master generates a stop condition to release the bus.



**Figure 13. Typical I<sup>2</sup>C Sequence**

To communicate with the device, the I<sup>2</sup>C master uses addresses shown in Figure 13. Transmission of read and write data can be by single-byte or multiple-byte data transfers.

### 7.3.7.2 Random Write

As shown in Figure 14, a single-byte data-write transfer begins with the master device transmitting a start condition followed by the I<sup>2</sup>C device address and the read/write bit. The read/write bit determines the direction of the data transfer. For a write data transfer, the read/write bit is a 0. After receiving the correct I<sup>2</sup>C device address and the read/write bit, the device responds with an acknowledge bit. Next, the master transmits the address byte corresponding to the internal memory address being accessed. After receiving the address byte, the device again responds with an acknowledge bit. Next, the master device transmits the data byte for writing to the memory address being accessed. After receiving the data byte, the device again responds with an acknowledge bit. Finally, the master device transmits a stop condition to complete the single-byte data-write transfer.

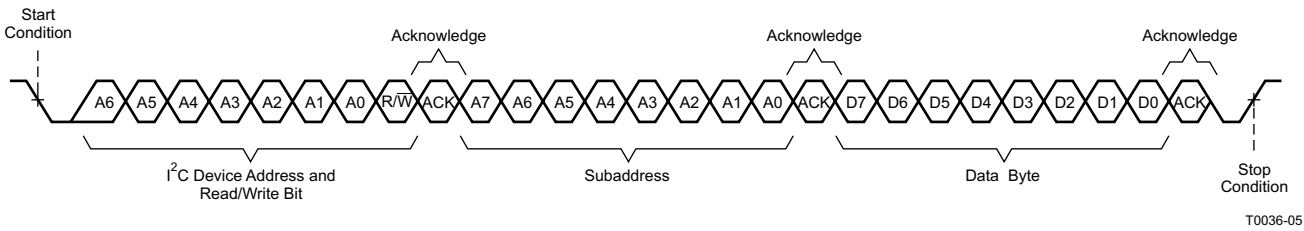


Figure 14. Random Write Transfer

### 7.3.7.3 Random Read

As shown in Figure 15, a single-byte data-read transfer begins with the master device transmitting a start condition followed by the I<sup>2</sup>C device address and the read/write bit. For the data-read transfer, the master device performs both a write and a following read. Initially, the master device performs a write to transfer the address byte of the internal memory address to be read. As a result, the read/write bit is a 0. After receiving the address and the read/write bit, the device responds with an acknowledge bit. In addition, after sending the internal memory address byte, the master device transmits another start condition followed by the device address and the read/write bit again. This time, the read/write bit is a 1, indicating a read transfer. After receiving the address and the read/write bit, the device again responds with an acknowledge bit. Next, the device transmits the data byte from the memory address being read. After receiving the data byte, the master device transmits a not-acknowledge followed by a stop condition to complete the single-byte data-read transfer.

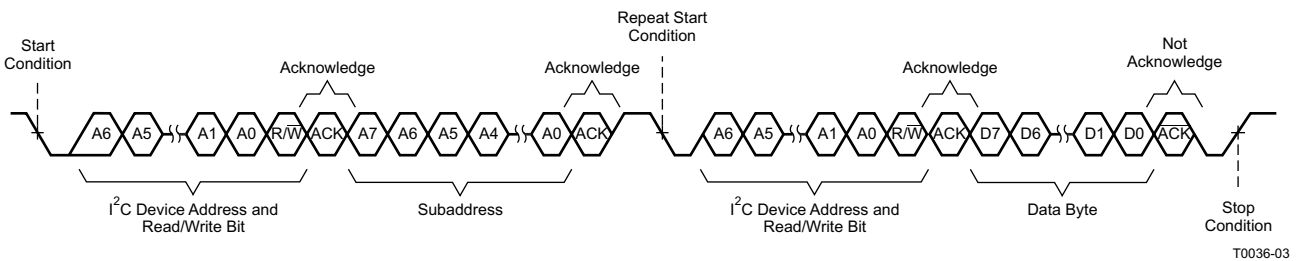


Figure 15. Random Read Transfer

### 7.3.7.4 Sequential Read

A sequential data-read transfer is identical to a single-byte data-read transfer except that the TAS5421-Q1 transmits multiple data bytes to the master device as shown in Figure 16. Except for the last data byte, the master device responds with an acknowledge bit after receiving each data byte and automatically increments the I<sup>2</sup>C subaddress by one. After receiving the last data byte, the master device transmits a not-acknowledge followed by a stop condition to complete the transfer.

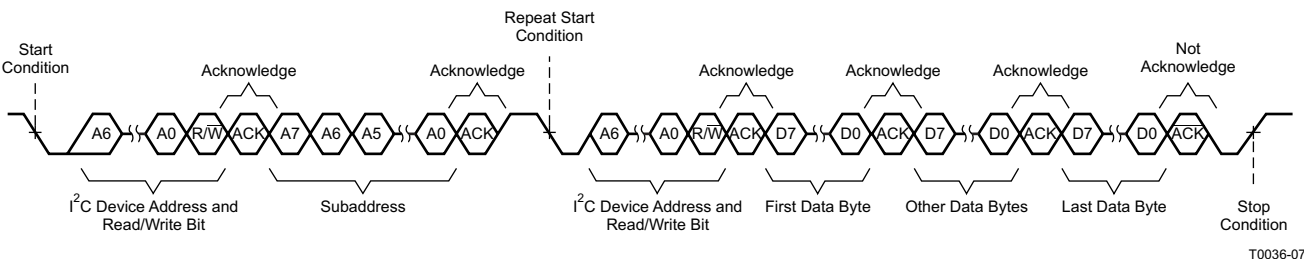


Figure 16. Sequential Read Transfer

## 7.4 Device Functional Modes

### 7.4.1 Hardware Control Pins

There are three discrete hardware pins for real-time control and indication of device status.

## Device Functional Modes (continued)

**FAULT** pin: This active-low open-drain output pin indicates the presence of a fault condition which requires the device to go into the Hi-Z mode. On assertion of this pin, the device has protected itself and the system from potential damage. The system can read the exact nature of the fault via I<sup>2</sup>C with the exception of PVDD undervoltage faults below POR, in which case the I<sup>2</sup>C bus is no longer operational.

**STANDBY** pin: Assertion of this active-low pin sends the device goes into a complete shutdown, limiting the current draw.

**MUTE** pin: On assertion of this active-high pin, the device is in mute mode. The output pins stop switching and audio does not pass from the input to the output. To place the device back into play mode, it is necessary to deassert this pin.

### 7.4.2 EMI Considerations

Automotive-level EMI performance depends on both careful integrated-circuit design and good system-level design. Controlling sources of electromagnetic interference (EMI) was a major consideration in all aspects of the design.

The design has minimal parasitic inductances due to the short leads on the package. This dramatically reduces the EMI that results from current passing from the die to the system PCB. The design incorporates circuitry that optimizes output transitions that cause EMI.

### 7.4.3 Operating Modes and Faults

The following tables list operating modes and faults.

**Table 2. Operating Modes**

STATE NAME	OUTPUT	OSCILLATOR	I <sup>2</sup> C
STANDBY	Hi-Z, floating	Stopped	Stopped
Load diagnostic	DC biased	Active	Active
Fault and mute	Hi-Z, floating	Active	Active
Play	Switching with audio	Active	Active

**Table 3. Faults and Actions**

FAULT EVENT	FAULT EVENT CATEGORY	MONITORING MODES	REPORTING METHOD	ACTION TYPE	ACTION RESULT	CLEARING
POR	Voltage fault	All	Not applicable	Hard mute (no ramp)	Standby	Self-clearing
UV or OV			I <sup>2</sup> C + $\overline{\text{FAULT}}$ pin			
Load dump <sup>(1)</sup>			$\overline{\text{FAULT}}$ pin			
OTSD	Thermal fault	Hi-Z, mute, play	I <sup>2</sup> C + $\overline{\text{FAULT}}$ pin	Hard mute (no ramp)	Hi-Z	Self-clearing
OC fault	Output channel fault	Play				
DC detect						
Load diagnostic - short	Diagnostic	Hi-Z	I <sup>2</sup> C	None	Hi-Z, re-run diagnostics	Clears on next diagnostic cycle
Load diagnostic - open					None	

(1) Tested in accordance with ISO7637-1

## 7.5 Register Maps

**Table 4. I<sup>2</sup>C Address**

DESCRIPTION	FIXED ADDRESS							READ/WRITE BIT	I <sup>2</sup> C ADDRESS
	MSB	6	5	4	3	2	1	LSB	
I <sup>2</sup> C write	1	1	0	1	1	0	0	0	0xD8
I <sup>2</sup> C read	1	1	0	1	1	0	0	1	0xD9

**Table 5. I<sup>2</sup>C Address Register Definitions**

ADDRESS	R/ $\bar{W}$	REGISTER DESCRIPTION
0x01	R	Latched fault register
0x02	R	Status and load diagnostics register
0x03	R/ $\bar{W}$	Control register

**Table 6. Fault Register (0x01)**

D7	D6	D5	D4	D3	D2	D1	D0	FUNCTION
0	0	0	0	0	0	0	0	No protection-created faults, default value
–	–	–	–	–	–	–	1	Reserved
–	–	–	–	–	–	1	–	Reserved
–	–	–	–	–	1	–	–	A load-diagnostics fault has occurred.
–	–	–	–	1	–	–	–	Overcurrent shutdown has occurred.
–	–	–	1	–	–	–	–	PVDD undervoltage has occurred.
–	–	1	–	–	–	–	–	PVDD overvoltage has occurred.
–	1	–	–	–	–	–	–	DC offset protection has occurred.
1	–	–	–	–	–	–	–	Overtemperature shutdown has occurred.

**Table 7. Status and Load Diagnostic Register (0x02)**

D7	D6	D5	D4	D3	D2	D1	D0	FUNCTION
0	0	0	0	0	0	0	0	No speaker-diagnostic-created faults, default value
–	–	–	–	–	–	–	1	Output short to PVDD is present.
–	–	–	–	–	–	1	–	Output short to ground is present.
–	–	–	–	–	1	–	–	Open load is present.
–	–	–	–	1	–	–	–	Shorted load is present.
–	–	–	1	–	–	–	–	In a fault condition
–	–	1	–	–	–	–	–	Performing load diagnostics
–	1	–	–	–	–	–	–	In mute mode
1	–	–	–	–	–	–	–	In play mode

**Table 8. Control Register (0x03)**

D7	D6	D5	D4	D3	D2	D1	D0	FUNCTION
0	1	1	1	1	0	0	0	26-dB gain, switching frequency set to 400 kHz , SpeakerGuard protection circuitry disabled
–	–	–	–	–	–	–	1	Switching frequency set to 500 khz
–	–	–	–	–	1	1	–	Reserved
–	–	1	1	0	–	–	–	SpeakerGuard protection circuitry set to 14-V peak output
–	–	1	0	1	–	–	–	SpeakerGuard protection circuitry set to 11.8-V peak output
–	–	1	0	0	–	–	–	SpeakerGuard protection circuitry set to 9.8-V peak output
–	–	0	1	1	–	–	–	SpeakerGuard protection circuitry set to 8.4-V peak output
–	–	0	1	0	–	–	–	SpeakerGuard protection circuitry set to 7-V peak output
–	–	0	0	1	–	–	–	SpeakerGuard protection circuitry set to 5.9-V peak output
–	–	0	0	0	–	–	–	SpeakerGuard protection circuitry set to 5-V peak output
0	0	–	–	–	–	–	–	Gain set to 20 dB
1	0	–	–	–	–	–	–	Gain set to 32 dB
1	1	–	–	–	–	–	–	Gain set to 36 dB

## 8 Application and Implementation

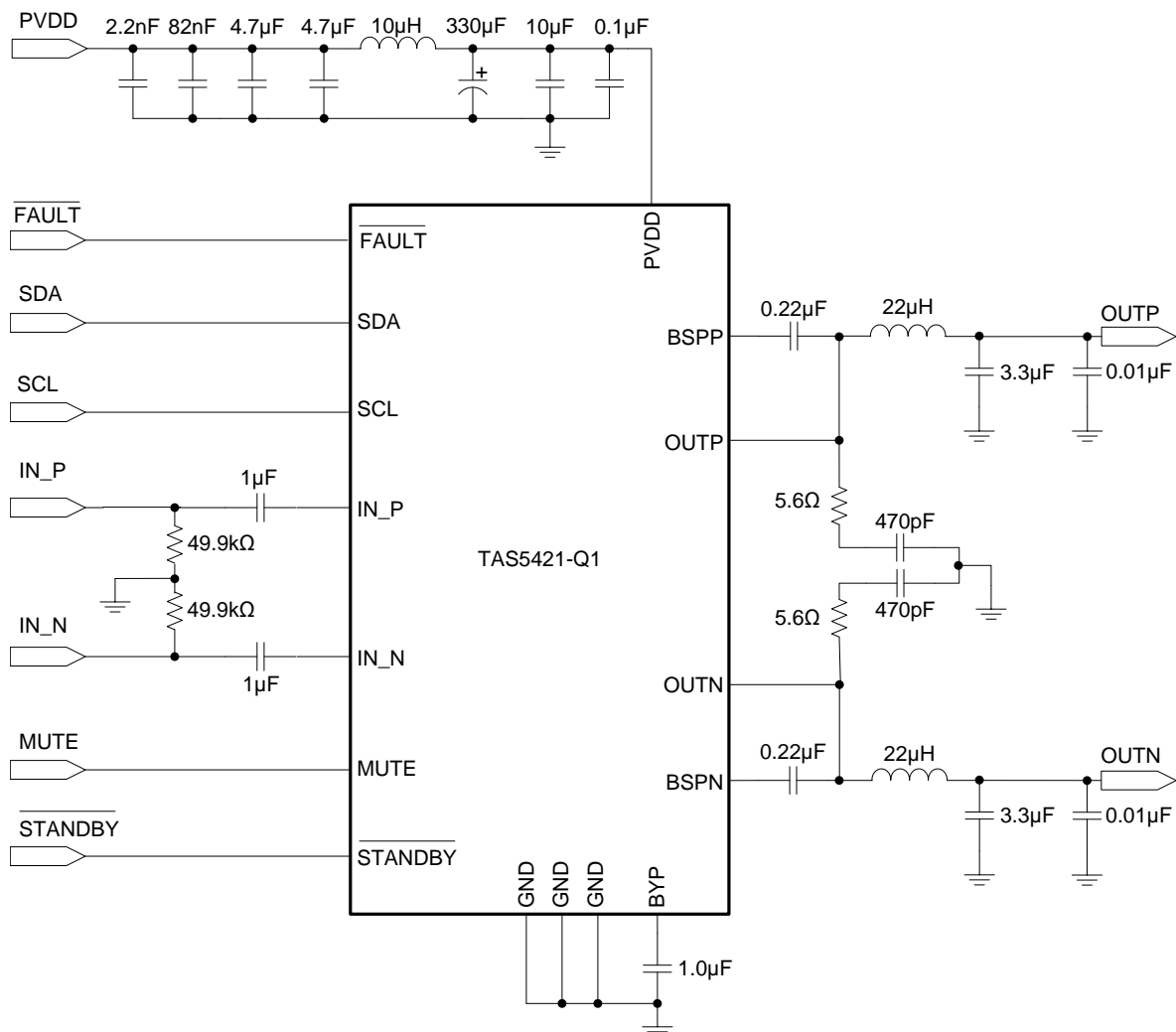
### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 8.1 Application Information

The device is a mono high-efficiency class-D audio amplifier. Typical use of the device is to amplify an audio input to drive a speaker. The intent of its use is for a bridge-tied load (BTL) application, not for support of single-ended configuration. This section presents how to use the device in the application, including what external components are necessary and how to connect unused pins.

### 8.2 Typical Application



**Figure 17. TAS5421-Q1 Typical Application Schematic**

## Typical Application (continued)

### 8.2.1 Design Requirements

- Power Supplies

The device needs only a single power supply compliant with the recommended operation range. The device is designed to work with either a vehicle battery or regulated power supply such as from a backup battery.

- Communication

The device communicates with the system controller with both discrete hardware control pins and with I<sup>2</sup>C. The device is an I<sup>2</sup>C slave and thus requires a master. If a master I<sup>2</sup>C-compliant device is not present in the system, it is still possible to use the device, but only with the default settings. Diagnostic information is limited to the discrete reporting FAULT pin.

- External Components

Table 9 lists the components required for the device.

**Table 9. Supporting Components**

EVM Designator	Quantity	Value	Size	Description	Use in Application
C7	1	10 $\mu$ F $\pm$ 10%	1206	X7R ceramic capacitor, 25-V	Power supply
C8	1	330 $\mu$ F $\pm$ 20%	10 mm	Low-ESR aluminum capacitor, 25-V	Power supply
C9, C16, C20	3	1 $\mu$ F $\pm$ 10%	0805	X7R ceramic capacitor, 25-V	Analog audio input filter, bypass
C10, C14	2	0.22 $\mu$ F $\pm$ 10%	0603	X7R ceramic capacitor, 25-V	Bootstrap capacitors
C11, C17	2	3.3 $\mu$ F $\pm$ 10%	0805	X7R ceramic capacitor, 25-V	Amplifier output filtering
C13, C15	2	470 pF $\pm$ 10%	0603	X7R ceramic capacitor, 250-V	Amplifier output snubbers
C6	1	0.1 $\mu$ F $\pm$ 10%	0603	X7R ceramic capacitor, 25-V	Power supply
C2	1	2200 pF $\pm$ 10%	0603	X7R ceramic capacitor, 50-V	Power supply
C3	1	0.082 $\mu$ F $\pm$ 10%	0603	X7R ceramic capacitor, 25-V	Power supply
C4, C5	2	4.7 $\mu$ F $\pm$ 10%	1206	X7R ceramic capacitor, 25-V	Power supply
C12, C18	2	0.01 $\mu$ F $\pm$ 10%	0603	X7R ceramic capacitor, 25-V	Output EMI filtering
L1	1	10 $\mu$ H $\pm$ 20%	13.5 mm $\times$ 13.5 mm	Shielded ferrite inductor	Power supply
L2	1	22 $\mu$ H $\pm$ 20%	8 mm $\times$ 8 mm	Coupled inductor	Amplifier output filtering
R5, R6	2	49.9 k $\Omega$ $\pm$ 1%	0805	Resistors, 0.125-W	Analog audio input filter
R4, R7	2	5.6 $\Omega$ $\pm$ 5%	0805	Resistors, 0.125-W	Output snubbers

#### 8.2.1.1 Amplifier Output Filtering

Output FETs drive the amplifier outputs in an H-bridge configuration. These transistors are either fully off or on. The result is a square-wave output signal with a duty cycle that is proportional to the amplitude of the audio signal. The amplifier outputs require a low-pass filter to filter out the PWM modulation carrier frequency. People frequently call this filter the L-C filter, due to the presence of an inductive element L and a capacitive element C to make up the 2-pole low-pass filter. The L-C filter attenuates the carrier frequency, reducing electromagnetic emissions and smoothing the current waveform which the load draws from the power supply. See the *Class-D LC Filter Design* application report, [SLOA119](#), for a detailed description on proper component selection and design of an L-C filter based upon the desired load and response.

#### 8.2.1.2 Amplifier Output Snubbers

A snubber is an RC network placed at the output of the amplifier to dampen ringing or overshoot on the PWM output waveform. Overshoot and ringing has several negative impacts including: potential EMI sources, degraded audio performance, and overvoltage stress of the output FETs or board components. For more information on the use and design of output snubbers, see the *Class-D Output Snubber Design Guide*, [SLOA201](#).

### 8.2.1.3 Bootstrap Capacitors

The output stage uses dual NMOS transistors; therefore, the circuit requires bootstrap capacitors for the high side of each output to turn on correctly. The required capacitor connection is from BSTN to OUTN and from BSTP to OUTP as shown in [Figure 17](#).

### 8.2.1.4 Analog Audio Input Filter

The circuit requires an input capacitor to allow biasing of the amplifier put to the proper dc level. The input capacitor and the input impedance of the amplifier form a high-pass filter with a  $-3$ -dB corner frequency determined by the equation:  $f = 1 / (2\pi R_{(i)} C_{(i)})$ , where  $R_{(i)}$  is the input impedance of the device based on the gain setting and  $C_{(i)}$  is the input capacitor value. [Table 10](#) lists largest recommended input capacitor values. Use a capacitor which matches the application need for the lowest frequency but does not exceed the values listed.

**Table 10. Recommended Input AC-Coupling Capacitors**

Gain (dB)	Typical Input Impedance (k $\Omega$ )	Input Capacitance ( $\mu$ F)	High-Pass Filter (Hz)
20	60	1	2.7
		1.5	1.8
26	30	1	5.3
		3.3	1.6
32	15	5.6	2.3
36	9	10	1.8

## 8.2.2 Detailed Design Procedure

- Step 1: Hardware Schematic Design: Using the Typical Application Schematic as a guide, integrate the hardware into the system schematic.
- Step 2: Following the recommended layout guidelines, integrate the device and its supporting components into the system PCB file.
- Step 3: Thermal Design: The device has an exposed thermal pad which requires proper soldering. For more information, see the *Semiconductor and IC Package Thermal Metrics*, [SPRA953](#), and the *PowerPAD Thermally Enhanced Package*, [SLMA002G](#), application reports.
- Step 4: Develop software: The EVM User's Guide has detailed instructions for how to set up the device, interpret diagnostic information, and so forth. For information about control registers, see the [Register Maps](#) section.
- For questions and support go to the [E2E forums](#).

## 8.2.3 Application Curves

See the [Typical Characteristics](#) section for application performance plots.

## 8.2.4 Unused Pin Connections

Even if unused, always connect pins to a fixed rail; do not leave them floating. Floating input pins represent an ESD risk, so adhere to the following guidance for each pin.

### 8.2.4.1 MUTE Pin

If the MUTE pin is unused in the application, connect it to GND through a high-impedance resistor.

### 8.2.4.2 $\overline{\text{STANDBY}}$ Pin

If the  $\overline{\text{STANDBY}}$  pin is unused in the application, connect it to a low-voltage rail such as 3.3 V or 5 V through a high-impedance resistor.

### 8.2.4.3 I<sup>2</sup>C Pins (SDA and SCL)

If there is no microcontroller in the system, use of the device without I<sup>2</sup>C communication is possible. In this situation, connect the SDA and SCL pins to 3.3 V.

#### **8.2.4.4 Terminating Unused Outputs**

If the  $\overline{\text{FAULT}}$  pin does not report to a system microcontroller in the application, connect it to GND.

#### **8.2.4.5 Using a Single-Ended Audio Input**

When using a single-ended audio source, ac-ground the negative input through a capacitor equal in value to the input capacitor on the positive input, and apply the audio source to the positive input. For best performance, the ac ground should be at the audio source instead of at the device input if possible.

## 9 Power Supply Recommendations

A car battery that can have a large voltage range most commonly provides power for the device. PVDD, a filtered battery voltage, is the supply for the output FETs and the low-side FET gate driver. Good power-supply decoupling is necessary, especially at low voltage and temperature levels. To meet the PVDD specifications in the [Electrical Characteristics](#) section, TI uses 10- $\mu$ F and 0.1- $\mu$ F ceramic capacitors near the PVDD pin along with a larger bulk 330- $\mu$ F electrolytic decoupling capacitor.

An internal linear regulator, which powers the analog circuitry, provides the voltage on the BYP pin. This supply requires an external bypass ceramic capacitor at the BYP pin.

## 10 Layout

### 10.1 Layout Guidelines

The EVM layout optimizes for thermal dissipation and EMC performance. The TAS5421-Q1 device has a thermal pad down, and good thermal conduction and dissipation require adequate copper area. Layout also affects EMC performance. TAS5421Q1EVM illustrations form the basis for the layout discussions.

### 10.2 Layout Examples

#### 10.2.1 Top Layer

The red boxes around number 1 are the copper ground on the top layer. Soldered directly to the thermal pad, this ground is the first significant thermal dissipation needed. There are vias that go to the other layers for further thermal relief, but vias have high thermal resistance. TI recommends that use of this top layer be mostly for thermal dissipation. A further recommendation is short routes from output pins to the second-order LC filter for EMC suppression. The number 2 arrow indicates these short routes. The shorter the distance, the less EMC radiates. A short route from the PVDD pin to the LC filter from the battery or power source, as indicated by the number 3 arrow, also improves EMC suppression. The red box around number 4 indicates the ground plane that is common to both OUTP and OUTN. Place the capacitors of the LC filter in this common ground plane to help with common-mode noise and short ground loops.

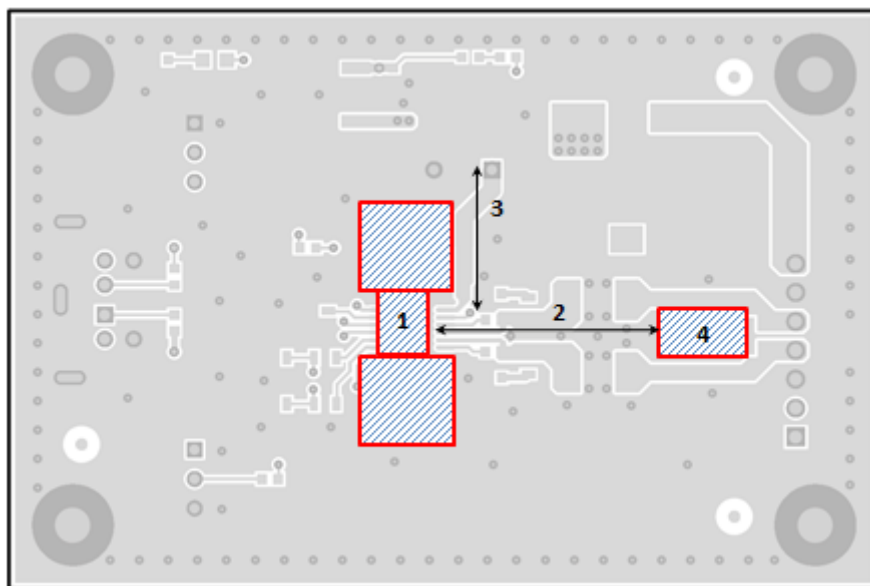
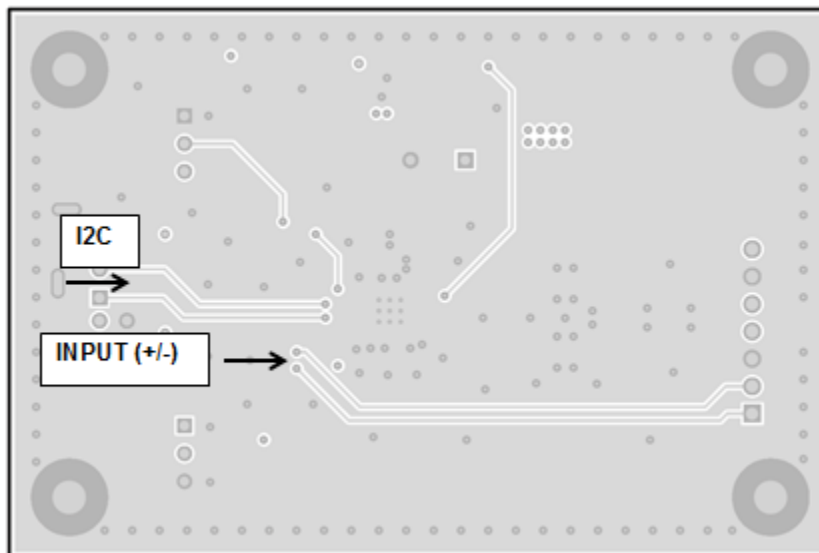


Figure 18. Top Layer

**Layout Examples (continued)**

**10.2.2 Second Layer – Signal Layer**

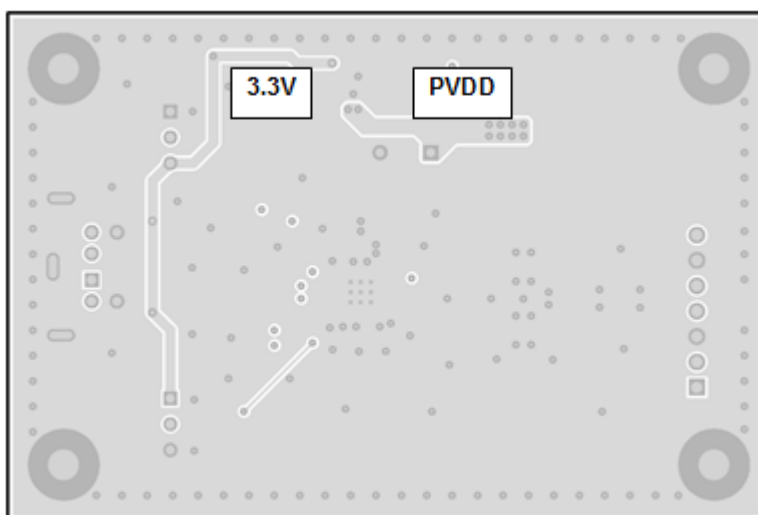
If possible, route the I<sup>2</sup>C and the positive and negative input traces close together and cover with ground plane, keeping the signals from noise.



**Figure 19. Signal Layer**

**10.2.3 Third Layer – Power Layer**

There is no need for a power plane, but TI recommends a wide single PVDD trace to keep the switching noise to a minimum and provide enough current to the device. The wide trace provides a low-impedance path from the power source to the PVDD pin and from the GND pin to the source return. Suppression of switching noise (ripple voltage) on both the positive and return (ground) paths requires a low impedance.



**Figure 20. Power Layer**

## Layout Examples (continued)

### 10.2.4 Bottom Layer – Ground Layer

The device has an exposed thermal pad on the bottom side for improved thermal performance. Conducting heat from the thermal pad to other layers requires thermal vias. Because the bottom layer is the secondary heat exchange surface to ambient, the thermal vias area must have low thermal resistance, that is, no signal vias or traces that can increase thermal resistance from the thermal vias to the bottom copper.

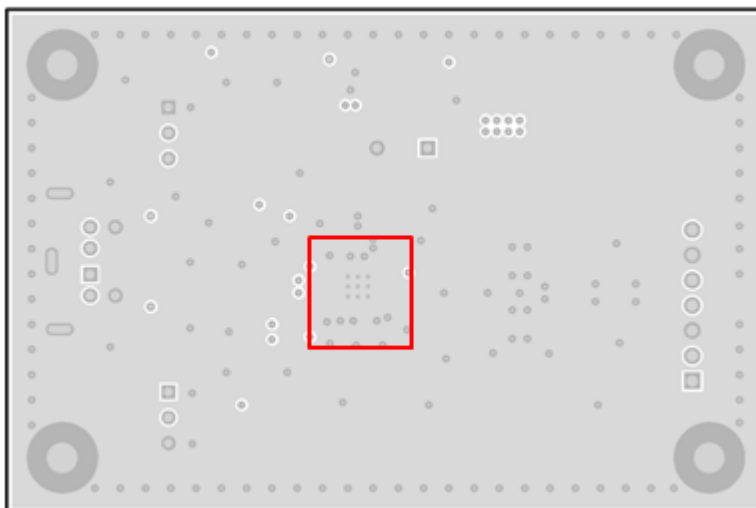


Figure 21. Bottom Layer

## 11 器件和文档支持

### 11.1 器件支持

#### 11.1.1 第三方产品免责声明

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All other trademarks are the property of their respective owners.

### 11.3 静电放电警告



ESD 可能会损坏该集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理措施和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

### 11.4 术语表

[SLYZ022](#) — TI 术语表。

这份术语表列出并解释术语、首字母缩略词和定义。

## 12 机械、封装和可订购信息

以下页中包括机械、封装和可订购信息。 这些信息是针对指定器件可提供的最新数据。 本数据随时可能发生变更并且不对本文档进行修订，恕不另行通知。 要获得这份数据表的浏览器版本，请查阅左侧导航栏。

**PACKAGING INFORMATION**

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
<a href="#">TAS5421QPWPRQ1</a>	Active	Production	HTSSOP (PWP)   16	2000   LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TAS5421
TAS5421QPWPRQ1.B	Active	Production	HTSSOP (PWP)   16	2000   LARGE T&R	Yes	NIPDAU	Level-3-260C-168 HR	-40 to 125	TAS5421

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

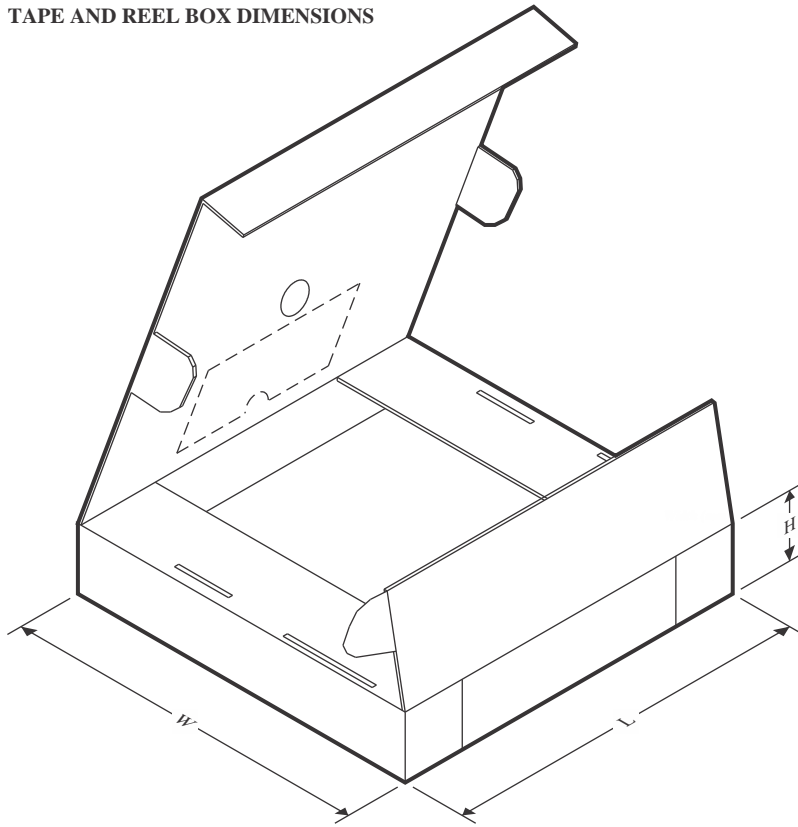
**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

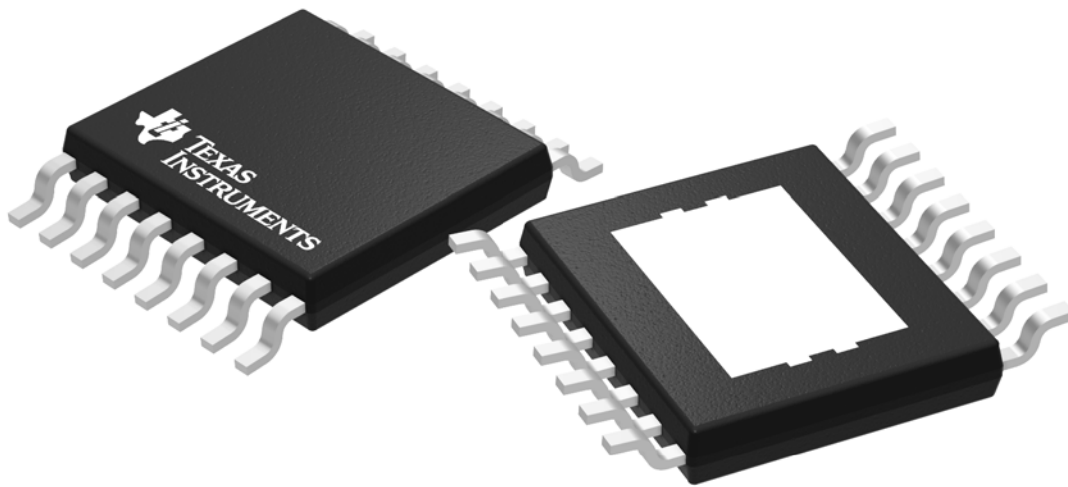
Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TAS5421QPWRQ1	HTSSOP	PWP	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TAS5421QPWRQ1	HTSSOP	PWP	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TAS5421QPWPRQ1	HTSSOP	PWP	16	2000	353.0	353.0	32.0
TAS5421QPWPRQ1	HTSSOP	PWP	16	2000	350.0	350.0	43.0



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

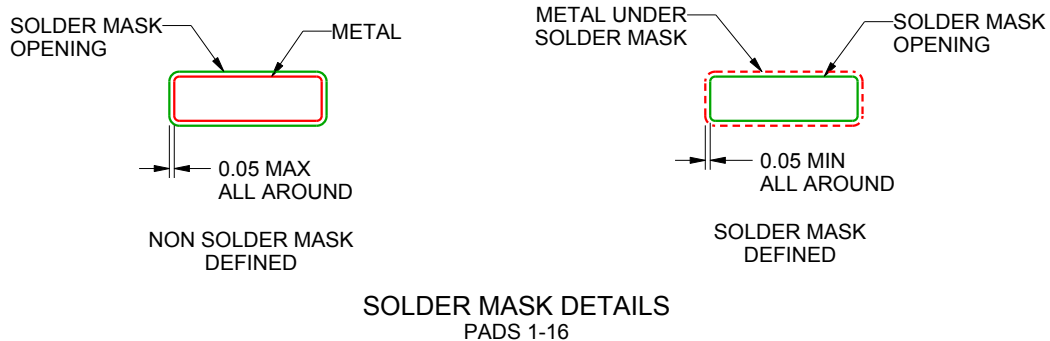
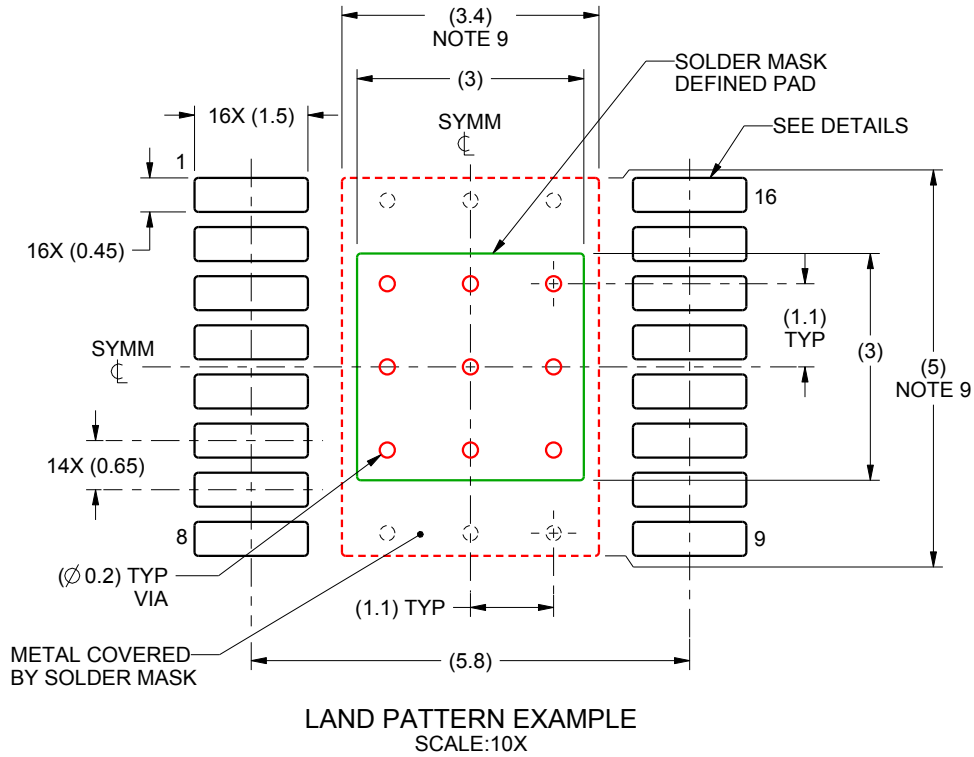


# EXAMPLE BOARD LAYOUT

PWP0016B

PowerPAD™ TSSOP - 1.2 mm max height

PLASTIC SMALL OUTLINE



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NOTES: (continued)

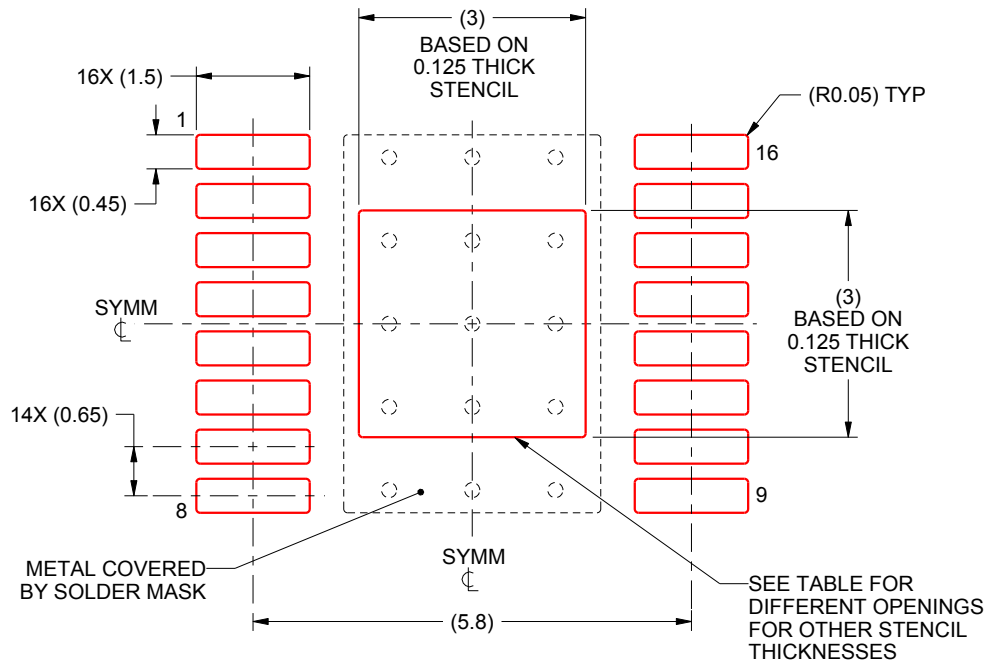
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature numbers SLMA002 ([www.ti.com/lit/slma002](http://www.ti.com/lit/slma002)) and SLMA004 ([www.ti.com/lit/slma004](http://www.ti.com/lit/slma004)).
9. Size of metal pad may vary due to creepage requirement.

# EXAMPLE STENCIL DESIGN

PWP0016B

PowerPAD™ TSSOP - 1.2 mm max height

PLASTIC SMALL OUTLINE



SOLDER PASTE EXAMPLE  
 EXPOSED PAD  
 100% PRINTED SOLDER COVERAGE BY AREA  
 SCALE:10X

STENCIL THICKNESS	SOLDER STENCIL OPENING
0.1	3.35 X 3.35
0.125	3 X 3 (SHOWN)
0.15	2.74 X 2.74
0.175	2.54 X 2.54

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NOTES: (continued)

- 10. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 11. Board assembly site may have different recommendations for stencil design.

## 重要通知和免责声明

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